

Search Notes

Application/Control No.

10/665,469

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2828

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search (see printout)	7/18/2005	PN